


<b>Search Notes</b>  	<b>Application/Control No.</b>  10578071	<b>Applicant(s)/Patent Under Reexamination</b>  IJZERMAN ET AL.
	<b>Examiner</b>  JOHN HEYMAN	<b>Art Unit</b>  2871

SEARCHED			
Class	Subclass	Date	Examiner
349	15	02/28/2008	JSH
349	15	01/03/2009	JSH
349	15, 64 ,65, 66	05/12/2009	JSH

SEARCH NOTES			
Search Notes		Date	Examiner
Consult Primary Examiner Andrew Schechter		02/27/ and 3/012008/	JSH
Text search entire Class 349		01/04/2009	JSH
Text search Class 349		05/12/2009	JSH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
349	See search History (both classified and text)	05/12/2009	JSH

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